



Power MOSFETS

DATASHEET

LM30185CA04A

N-Channel AND P-Channel
Enhancement Mode MOSFET



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Quality Management Systems

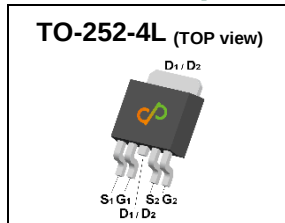
ISO 9001:2015 Certificate

LM30185CAO4A

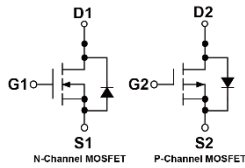


N-Channel AND P-Channel Enhancement Mode MOSFET

Pin Description



Symbol



Ordering Information

Symbol	N-Channel	P-Channel	Unit
V_{DSS}	30	-30	V
$R_{DS(ON)-Max}$	18.5	32	m Ω
I_D	33	-25	A

Feature

- Reliable and Rugged
- ROHS Compliant & Halogen-Free
- 100% UIS Tested

Applications

- Fan Motor Control
- Synchronous Rectification

Ordering Information

Orderable Part Number	Package Type	Form	Shipping	Marking
LM30185CAO4A	TO-252-4L	Tape & Reel	3000 / Tape & Reel	30185 □□□□□□

Note : □□□□□□ = Lot Code

Absolute Maximum Ratings (T_J=25°C Unless Otherwise Noted)

Symbol	Parameter	N-Channel	P- Channel	Unit
V_{DSS}	Drain-Source Voltage	30	-30	V
V_{GSS}	Gate-Source Voltage	±20	±20	V
T_J	Maximum Junction Temperature	150	150	°C
T_{STG}	Storage Temperature Range	-55 to 150	-55 to 150	°C
I_S	Diode Continuous Forward Current	$T_C=25^\circ\text{C}$ 18.2	-18.2	A
$I_{DM}^{①}$	Pulse Drain Current Tested	$T_C=25^\circ\text{C}$ 82	-62	A
I_D	Continuous Drain Current	$T_C=25^\circ\text{C}$ 33 $T_C=100^\circ\text{C}$ 21	-25 -16	A
P_D	Maximum Power Dissipation	$T_C=25^\circ\text{C}$ 20 $T_C=100^\circ\text{C}$ 8		W
I_D	Continuous Drain Current	$T_A=25^\circ\text{C}$ 11 $T_A=70^\circ\text{C}$ 8.5	-8 -6.5	A
P_D	Maximum Power Dissipation	$T_A=25^\circ\text{C}$ 2.1 $T_A=70^\circ\text{C}$ 1.3		W
$I_{AS}^{②}$	Avalanche Current, Single pulse	L=0.1mH 16 L=0.5mH 8.5	-19 -11	A
$E_{AS}^{②}$	Avalanche Energy, Single pulse	L=0.1mH 12.8 L=0.5mH 18	18 30	mJ

Thermal Characteristics

Symbol	Parameter	Rating	Unit
$R_{\theta JC}$	Thermal Resistance-Junction to Case	Steady State 6.25	°C/W
$R_{\theta JA}^{③}$	Thermal Resistance-Junction to Ambient	Steady State 60	°C/W

Note ① : Max. current is limited by junction temperature.

Note ② : UIS tested and pulse width are limited by maximum junction temperature 150°C

Note ③ : Surface Mounted on 1in² FR-4 board with 1oz.

N-Channel Electrical Characteristics (T_J=25°C Unless Otherwise Noted)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
Static Electrical Characteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _{DS} =250uA	30	-	-	V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =24V, V _{GS} =0V	-	-	1	uA
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _{DS} =250uA	1	1.5	2	V
I _{GSS}	Gate Leakage Current	V _{GS} =±20V, V _{DS} =0V	-	-	±100	nA
R _{DS(ON)} ④	Drain-Source On-state Resistance	V _{GS} =10V, I _{DS} =6A	-	15.5	18.5	mΩ
		V _{GS} =4.5V, I _{DS} =4A	-	20	26	
gfs	Forward Transconductance	V _{DS} =5V, I _{DS} =6A	-	9.6	-	S
Dynamic Characteristics ⑥						
R _G	Gate Resistance	V _{GS} =0V,V _{DS} =0V, Freq.=1MHz	-	3	-	Ω
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =15V, Freq.=1MHz	-	518	-	pF
C _{oss}	Output Capacitance		-	73	-	
C _{rss}	Reverse Transfer Capacitance		-	63	-	
td(ON)	Turn-on Delay Time	V _{GS} =10V,V _{DS} =15V, Id=1A,RGEN=3Ω	-	6	-	nS
tr	Turn-on Rise Time		-	3.4	-	
td(OFF)	Turn-off Delay Time		-	19	-	
tf	Turn-off Fall Time		-	10.5	-	
Qg	Total Gate Charge	V _{GS} =4.5V,V _{DS} =15V Id=6A	-	7.3	-	nC
Qg	Total Gate Charge	V _{GS} =10V,V _{DS} =15V, Id=6A	-	15	-	
Qgs	Gate-Source Charge		-	2.7	-	
Qgd	Gate-Drain Charge		-	3.3	-	
Source-Drain Characteristics						
VSD ④	Diode Forward Voltage	ISD=1A, VGS=0V	-	0.75	1.1	V
trr	Reverse Recovery Time	IF=1A, VR=10	-	9	-	nS
Qrr	Reverse Recovery Charge	dIF/dt=100A/μs	-	3	-	nC

Note ④ : Pulse test (pulse width≤300us, duty cycle≤2%).

Note ⑤ : Guaranteed by design, not subject to production testing.

N-Channel Typical Characteristics

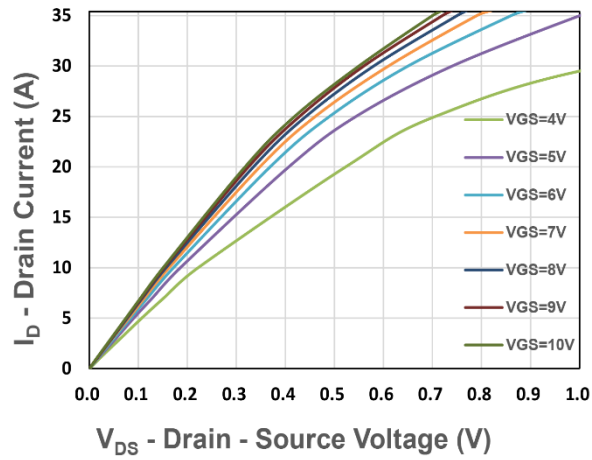


Figure 1. Output Characteristics

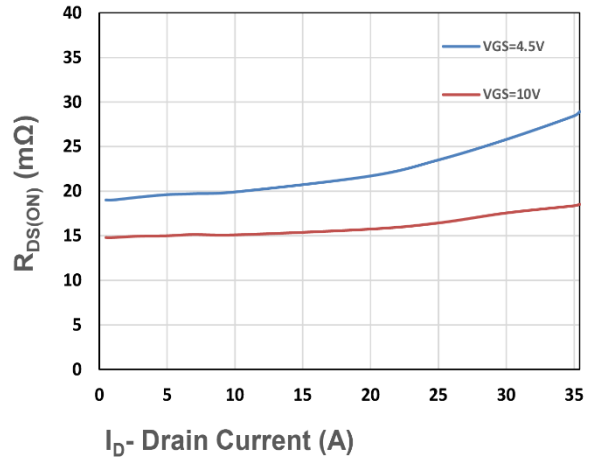


Figure 2. On-Resistance vs. I_D

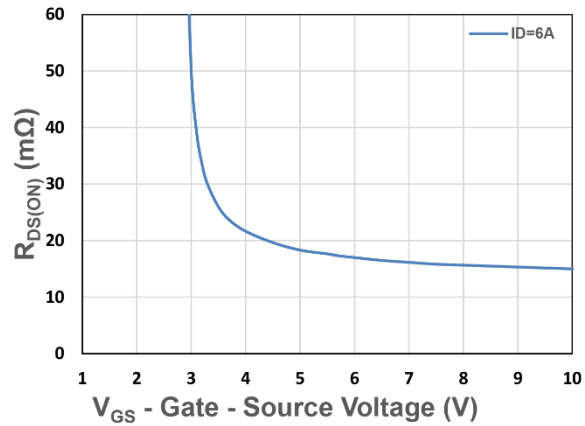


Figure 3. On-Resistance vs. V_{GS}

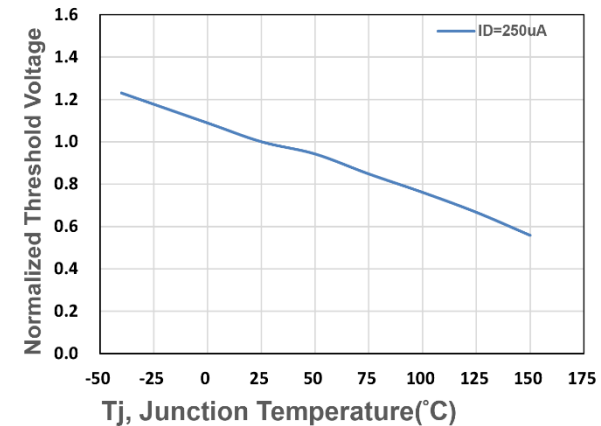


Figure 4. Gate Threshold Voltage

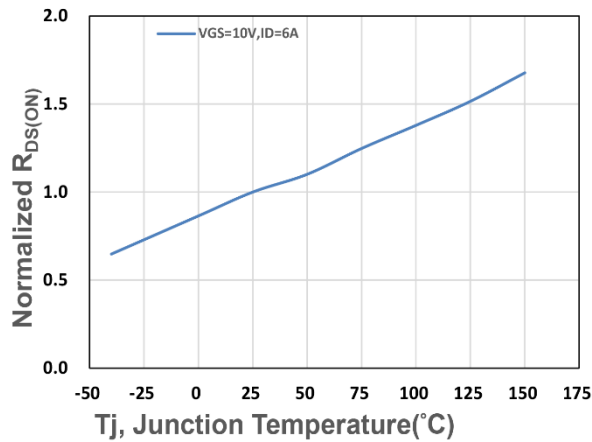


Figure 5. Drain-Source On Resistance

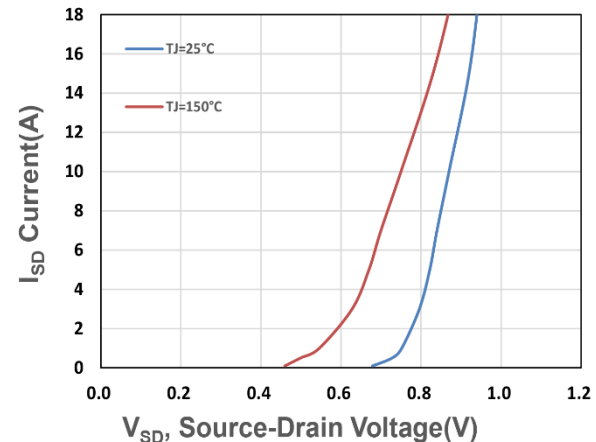


Figure 6. Source-Drain Diode Forward

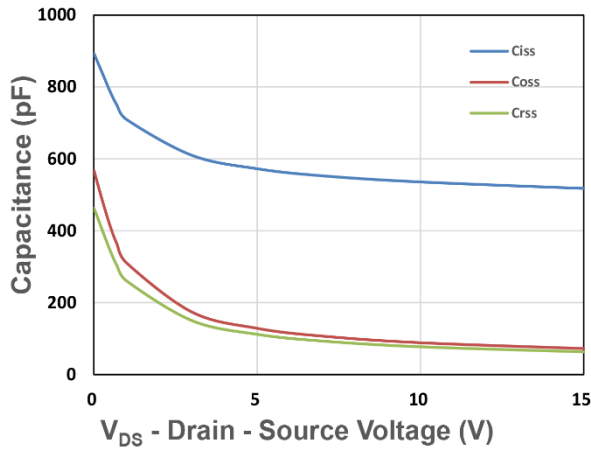


Figure 7. Capacitance

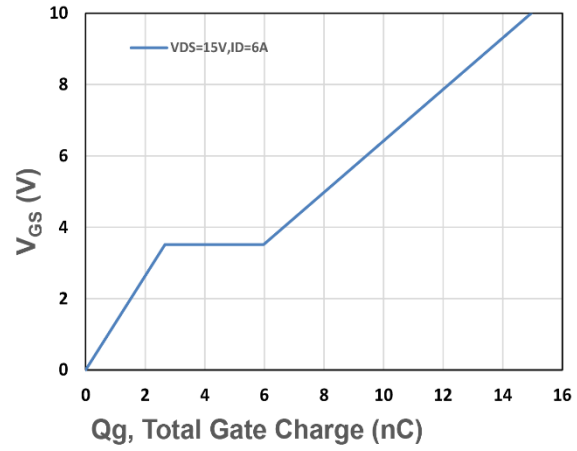


Figure 8. Gate Charge Characteristics

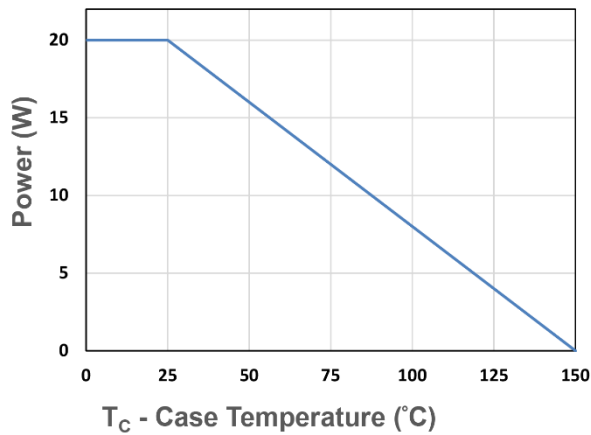


Figure 9. Power Dissipation

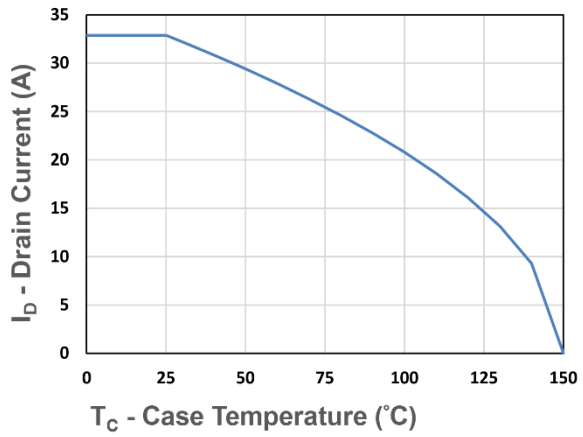


Figure 10. Drain Current

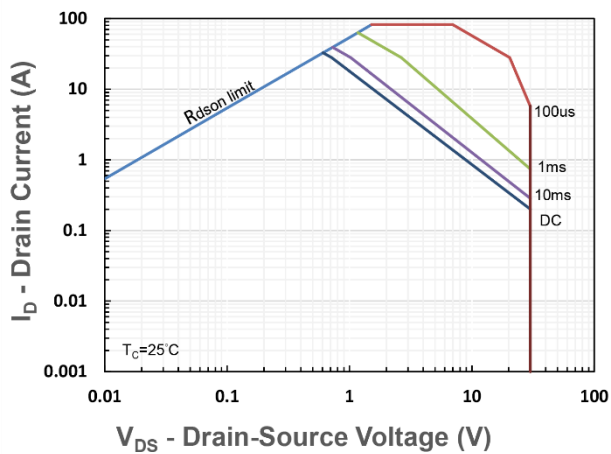


Figure 11. Safe Operating Area

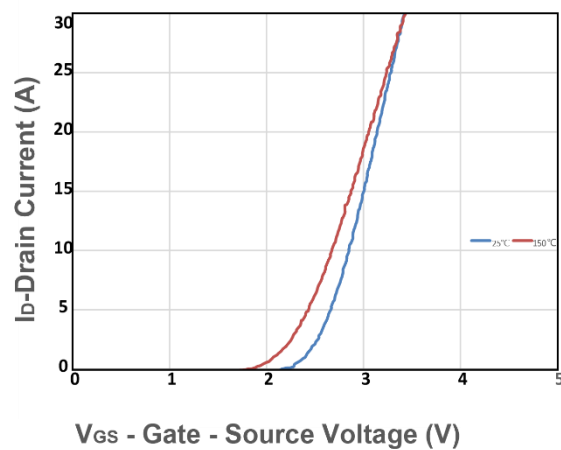


Figure 12. Transfer Characteristics

P-Channel Electrical Characteristics (T_J=25°C Unless Otherwise Noted)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
Static Electrical Characteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _{DS} =-250uA	-30	-	-	V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =-24V, V _{GS} =0V	-	-	-1	uA
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _{DS} =-250uA	-1	-1.5	-2	V
I _{GSS}	Gate Leakage Current	V _{GS} =±20V, V _{DS} =0V	-	-	±100	nA
R _{DS(ON)} ^④	Drain-Source On-state Resistance	V _{GS} =-10V, I _{DS} =-6A	-	26.5	32	mΩ
		V _{GS} =-4.5V, I _{DS} =-4A	-	35.5	46	
gfs	Forward Transconductance	V _{DS} =-5V, I _{DS} =-6A	-	11	-	S
Dynamic Characteristics ^⑤						
R _G	Gate Resistance	V _{GS} =0V,V _{DS} =0V, Freq.=1MHz	-	16	-	Ω
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =-15V, Freq.=1MHz	-	894	-	pF
C _{oss}	Output Capacitance		-	98	-	
C _{rss}	Reverse Transfer Capacitance		-	74	-	
td(ON)	Turn-on Delay Time	V _{GS} =-10V,V _{DS} =-15V, I _D =-1A,R _{GEN} =3Ω	-	6	-	nS
t _r	Turn-on Rise Time		-	3.3	-	
t _{d(OFF)}	Turn-off Delay Time		-	66.8	-	
t _f	Turn-off Fall Time		-	33	-	
Q _g	Total Gate Charge	V _{GS} =-4.5V,V _{DS} =-15V I _D =-6A	-	9	-	nC
Q _g	Total Gate Charge	V _{GS} =-10V,V _{DS} =-15V, I _D =-6A	-	19	-	
Q _{gs}	Gate-Source Charge		-	4.1	-	
Q _{gd}	Gate-Drain Charge		-	3.2	-	
Source-Drain Characteristics						
V _{SD} ^④	Diode Forward Voltage	I _{SD} =-1A, V _{GS} =0V	-	-0.75	-1.1	V
t _{rr}	Reverse Recovery Time	I _F =-1A, V _R =-10V	-	10	-	nS
Q _{rr}	Reverse Recovery Charge	dl _F /dt=100A/μs	-	3	-	nC

P-Channel Typical Characteristics

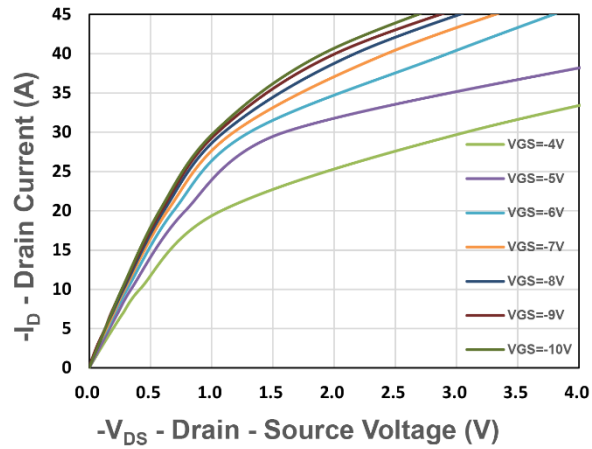


Figure 1. Output Characteristics

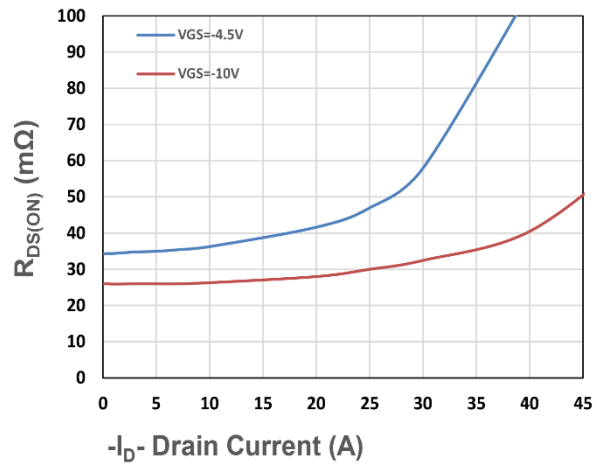


Figure 2. On-Resistance vs. ID

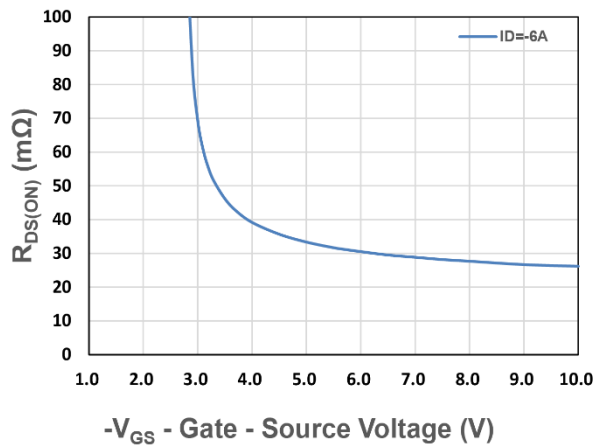


Figure 3. On-Resistance vs. VGS

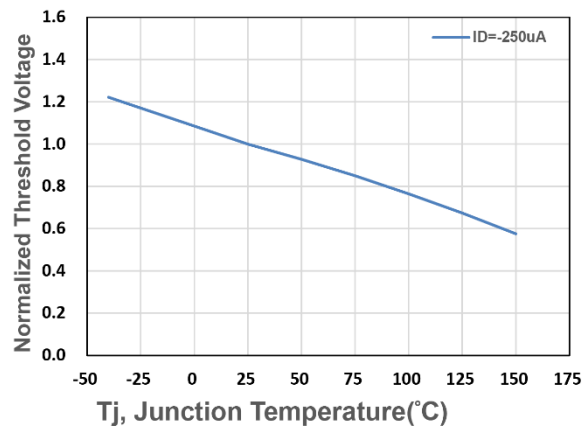


Figure 4. Gate Threshold Voltage

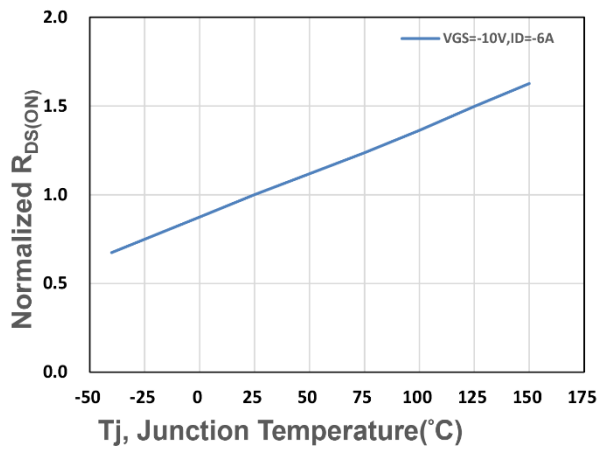


Figure 5. Drain-Source On Resistance

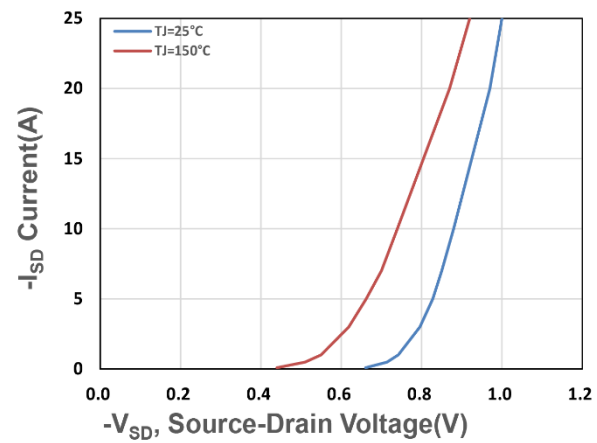


Figure 6. Source-Drain Diode Forward

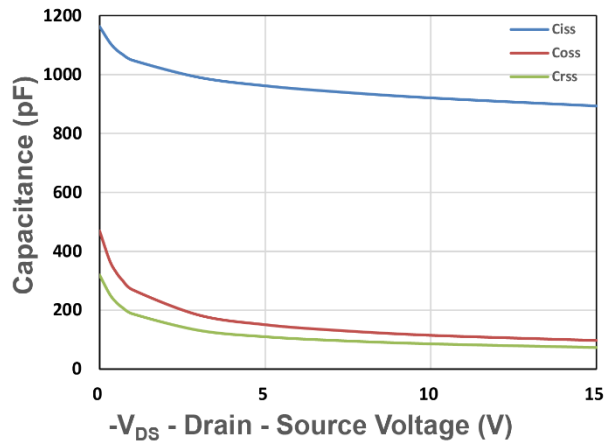


Figure 7. Capacitance

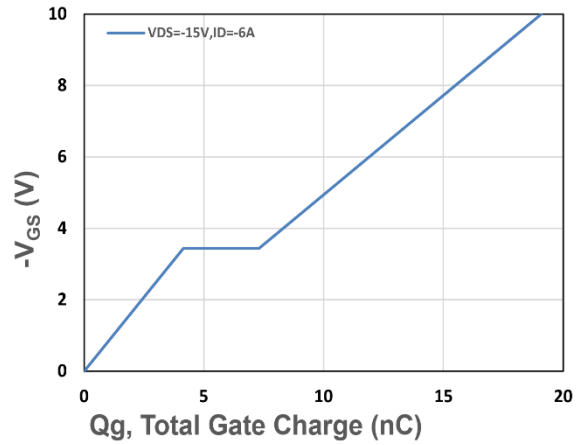


Figure 8. Gate Charge Characteristics

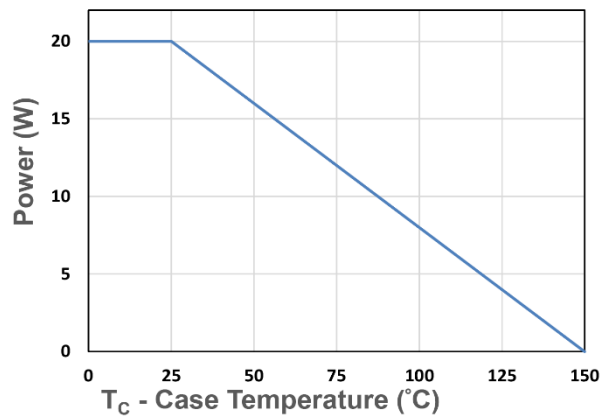


Figure 9. Power Dissipation

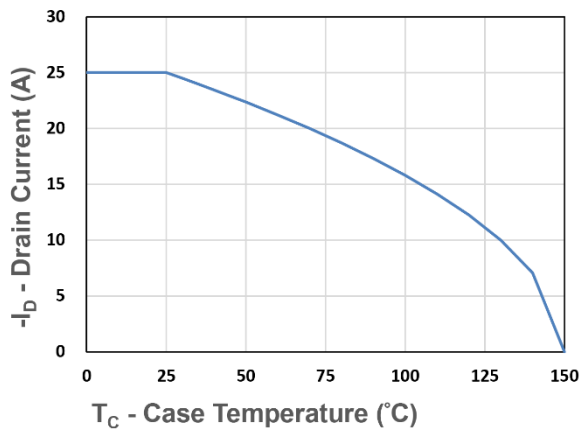


Figure 10. Drain Current

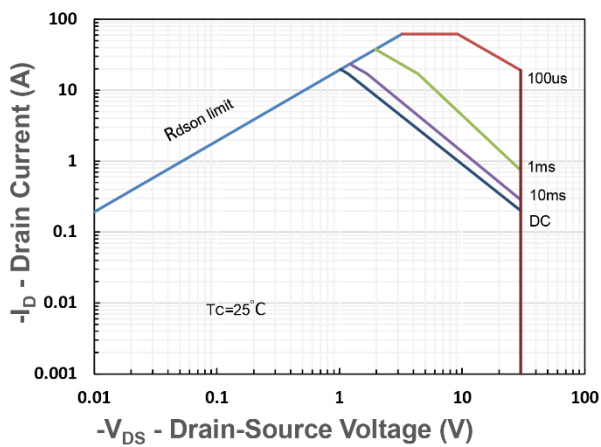


Figure 11. Safe Operating Area

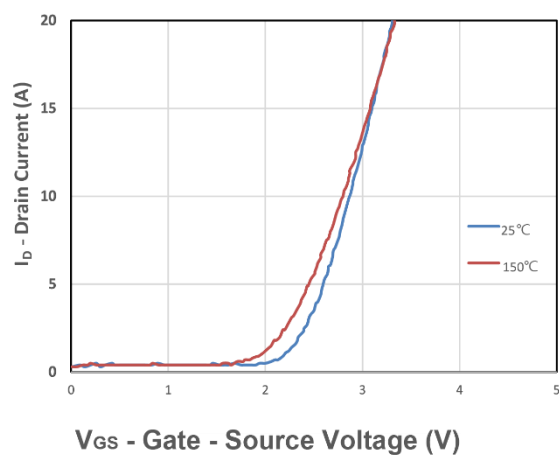


Figure 12. Transfer Characteristics

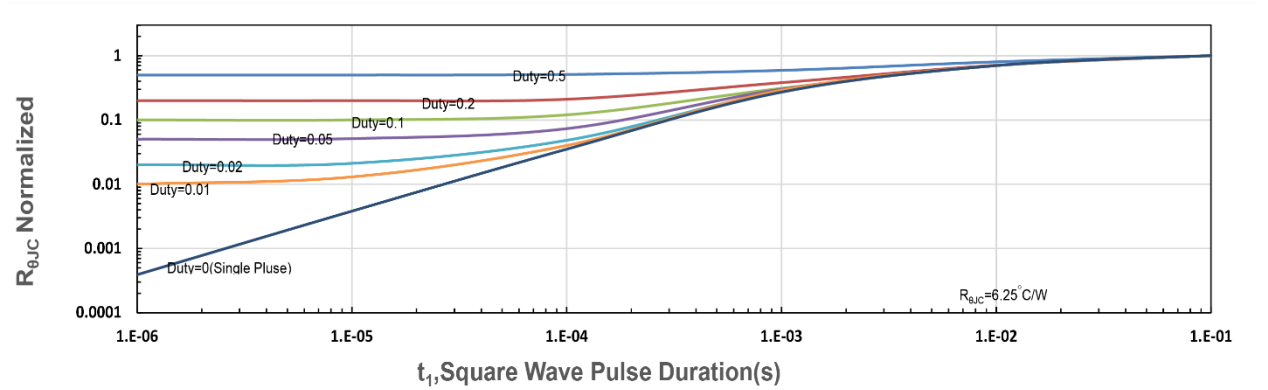


Figure 13. $R_{\theta JC}$ Transient Thermal Impedance